

Notice of References Cited	Application/Control No. 10/037,321	Applicant(s)/Patent Under Reexamination TRANCHINA ET AL.	
	Examiner KIEU-OANH T BUI	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,794,164	08-1998	Beckert et al.	701
	B	US-6,283,299 B1	09-2001	Lee	206
	C	US-6,339,696 B1	01-2002	Chan et al.	455
	D	US-5,790,787	08-1998	Scott et al.	395
	E	US-6,330,337 B1	12-2001	Nicholson et al.	381
	F	US-6,057,814	05-2000	Kalt	345
	G	US-6,434,459 B2	08-2000	Wong et al.	701
	H	US-5,957,985	09-1999	Wong et al.	701
	I	US-6,058,288	05-2000	Reed et al.	455
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.